



FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
4001-1154SERIAL NO.
10/673,170**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use several sheets if necessary)

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APPLICANT
Manfred SCHUSTERFILING DATE
September 30, 2003GROUP
Unknown**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

J.Y.	1	S.W. Wilkins et al., "Phase-Contrast Imaging Using Polychromatic Hard X-Rays," Nature, V. 384, 1996, pp. 335-338.
J.Y.	2	M. Schuster et al., "Laterally Graded Multilayer Optics for X-Ray Analysis," Proc. SPIE, V. 3767, 1999, pp. 183-198.
J.Y.	3	F.S. Crawford, Jr., "Schwingungen und Wellen," Vieweg, Braunschweig, 1989, pp. 259-271.
J.Y.	4	L.M.N. Távora et al., "Optimisation of Transmission Target X-Ray Tubes for Imaging Applications using Monte Carlo Based Methods," SPIE, V. 3771, 1999, pp. 61-71.
J.Y.	5	M.A. Piestrup et al., "A Design of Mammography Units Using a Quasimonochromatic X-Ray Source," Review of Scientific Instruments, V. 72, 2001, pp. 2159-2170.
J.Y.	6	V.G. Baryshevsky et al., "A Comparative Analysis of Various Mechanisms for the Generation of X-Rays by Relativistic Particles," Nuclear Instruments and Methods in Physics Research, V. 228, 1985, pp. 490-495.
J.Y.	7	Wolfgang Knüpfer et al., "Channelingstrahlung," Physik in unserer Zeit, V. 6, 1984, pp. 163-172.
J.Y.	8	Akira Tsunemi et al., "Backward Compton Scattering of Picosecond CO ₂ Laser Pulses Using Relativistic Electron Beam for the Bright X-Ray Generation," IEEE, V. 3, 1999, pp. 926-927.
J.Y.	9	Akira Tsunemi et al., "Ultra-Bright X-Ray Generation using Inverse Compton Scattering of Picosecond CO ₂ Laser Pulses," IEEE, V. 4, 1999, pp. 2552-2554.

EXAMINER

Jeric Yun

DATE CONSIDERED

9-7-04

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.